Report No: CCISE181205409

# **FCC REPORT**

Applicant: Sun Cupid Technology (HK) Ltd.

Address of Applicant: 16/F, CEO Tower, 77 Wing Hong Street, Cheung Sha Wan,

Kowloon, Hong Kong.

#### **Equipment Under Test (EUT)**

Product Name: LTE Smart phone

Model No.: N6201L, G4

Trade mark: NUU

FCC ID: 2ADINN6201L

Applicable standards: FCC CFR Title 47 Part 15 Subpart B

Date of sample receipt: 14 Dec., 2018

**Date of Test:** 14 Dec., to 22 Dec., 2018

Date of report issued: 25 Dec., 2018

Test Result: PASS \*

#### Authorized Signature:



#### Bruce Zhang Laboratory Manager

This report details the results of the testing carried out on one sample. The results contained in this test report do not relate to other samples of the same product and does not permit the use of the CCIS product certification mark. The manufacturer should ensure that all products in series production are in conformity with the product sample detailed in this report.

This report may only be reproduced and distributed in full. If the product in this report is used in any configuration other than that detailed in the report, the manufacturer must ensure the new system complies with all relevant standards.

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<sup>\*</sup> In the configuration tested, the EUT complied with the standards specified above.





# 2 Version

Version No.	Date	Description
00	25 Dec., 2018	Original

Tested by: ( over (her Date: 25 Dec., 2018

Test Engineer

Reviewed by: Date: 25 Dec., 2018

**Project Engineer** 





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# 4 Test Summary

Test Item	Section in CFR 47	Result
Conducted Emission	Part 15.107	Pass
Radiated Emission	Part 15.109	Pass

Remark

Pass: The EUT complies with the essential requirements in the standard.

N/A: The EUT not applicable of the test item.



# **5** General Information

# **5.1 Client Information**

Applicant:	Sun Cupid Technology (HK) Ltd.	
Address:	16/F, CEO Tower, 77 Wing Hong Street, Cheung Sha Wan, Kowloon, Hong Kong.	
Manufacturer	Sun Cupid Technology (HK) Ltd.	
Address:	16/F, CEO Tower, 77 Wing Hong Street, Cheung Sha Wan, Kowloon, Hong Kong.	
Factory:	SUNCUPID (ShenZhen) Electronic Ltd	
Address:	Baolong Industrial City, Longgang District, Shenzhen Hi-Tech Road, Building 1, A 7, China.	

# 5.2 General Description of E.U.T.

Product Name:	LTE Smart phone
Model No.:	N6201L, G4
Power supply:	Rechargeable Li-ion Battery DC 3.85V, 3750mAh
AC adapter :	Model: HJ-FC001K7-US Input: AC100-240V, 50/60Hz, 0.6A Output: DC 5.0V, 2000mA / DC 9.0V, 2000mA
Test Sample Condition:	The test samples were provided in good working order with no visible defects.
Remarks:	N6201L, G4 were identical inside, the electrical circuit design, layout, components used and internal wiring, with only difference being model name and for different areas, They all have two memory configurations, 1:6G(RAM) + 64G(ROM); 2: 6G(RAM) + 128G(ROM).



### 5.3 Test Mode

Operating mode	Detail description	
PC mode	Keep the EUT in Downloading mode(Worst case)	
Charging+Recording mode	Keep the EUT in Charging+Recording mode	
Charging+Playing mode	Keep the EUT in Charging+Playing mode	
FM mode	Keep the EUT in FM receiver mode	
GPS mode	Keep the EUT in GPS receiver mode	

The sample was placed 0.8m above the ground plane of 3m chamber. Measurements in both horizontal and vertical polarities were performed. During the test, each emission was maximized by: having the EUT continuously working, investigated all operating modes, rotated about all 3 axis (X, Y & Z) and considered typical configuration to obtain worst position, manipulating interconnecting cables, rotating the turntable, varying antenna height from 1m to 4m in both horizontal and vertical polarizations. The emissions worst-case are shown in Test Results of the following pages.

# **5.4 Measurement Uncertainty**

Parameters	Expanded Uncertainty
Conducted Emission (9kHz ~ 30MHz)	±2.22 dB (k=2)
Radiated Emission (9kHz ~ 30MHz)	±2.76 dB (k=2)
Radiated Emission (30MHz ~ 1000MHz)	±4.28 dB (k=2)
Radiated Emission (1GHz ~ 18GHz)	±5.72 dB (k=2)
Radiated Emission (18GHz ~ 40GHz)	±2.88 dB (k=2)

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# 5.5 Description of Support Units

Manufacturer	Description	Model	Serial Number	FCC ID/DoC
DELL	PC	OPTIPLEX745	N/A	DoC
DELL	MONITOR	E178FPC	N/A	DoC
DELL	KEYBOARD	SK-8115	N/A	DoC
DELL	MOUSE	MOC5UO	N/A	DoC
LENOVO	Laptop	SL510	2847A65	DoC

# 5.6 Related Submittal(s) / Grant (s)

This is an original grant, no related submittals and grants.

## 5.7 Description of Cable Used

Cable Type	Description	Length	From	То
Detached USB Cable	Shielding	1.0m	EUT	PC/Adapter
Type C to 3.5mm	Unshielded	0.1m	EUT	FM/Earphone

# 5.8 Laboratory Facility

The test facility is recognized, certified, or accredited by the following organizations:

FCC - Registration No.: 727551

Shenzhen Zhongjian Nanfang Testing Co., Ltd. has been accredited as a testing laboratory by FCC (Federal Communications Commission). The Registration No. is 727551.

IC - Registration No.: 10106A-1

The 3m Semi-anechoic chamber of Shenzhen Zhongjian Nanfang Testing Co., Ltd. has been Registered by Certification and Engineering Bureau of Industry Canada for radio equipment testing with Registration No.: 10106A-1.

CNAS - Registration No.: CNAS L6048

Shenzhen Zhongjian Nanfang Testing Co., Ltd. is accredited to ISO/IEC 17025:2005 General Requirements for the Competence of Testing and Calibration laboratories for the competence of testing. The Registration No. is CNAS L6048.

A2LA - Registration No.: 4346.01

This laboratory is accredited in accordance with the recognized International Standard ISO/IEC 17025:2005 General requirements for the competence of testing and calibration laboratories. The test scope can be found as below link: https://portal.a2la.org/scopepdf/4346-01.pdf

# 5.9 Laboratory Location

Shenzhen Zhongjian Nanfang Testing Co., Ltd.

Address: No. B-C, 1/F., Building 2, Laodong No.2 Industrial Park, Xixiang Road,

Bao'an District, Shenzhen, Guangdong, China

Tel: +86-755-23118282, Fax: +86-755-23116366

Email: info@ccis-cb.com, Website: http://www.ccis-cb.com

Shenzhen Zhongjian Nanfang Testing Co., Ltd.
No. B-C, 1/F., Building 2, Laodong No.2 Industrial Park, Xixiang Road,
Bao'an District, Shenzhen, Guangdong, China
Telephone: +86 (0) 755 2311 8282 Fax: +86 (0) 755 2311 6366



# 5.10 Test Instruments list

Radiated Emission:					
Test Equipment	Manufacturer	Model No.	Serial No.	Cal. Date (mm-dd-yy)	Cal. Due date (mm-dd-yy)
3m SAC	SAEMC	9m*6m*6m	966	07-22-2017	07-21-2020
Loop Antenna	SCHWARZBECK	FMZB1519B	00044	03-16-2018	03-15-2019
BiConiLog Antenna	SCHWARZBECK	VULB9163	497	03-16-2018	03-15-2019
Horn Antenna	SCHWARZBECK	BBHA9120D	916	03-16-2018	03-15-2019
Horn Antenna	SCHWARZBECK	BBHA9120D	1805	06-22-2017	06-21-2020
Horn Antenna	SCHWARZBECK	BBHA 9170	BBHA9170582	11-21-2018	11-20-2019
EMI Test Software	AUDIX	E3	\	ersion: 6.110919	b
Pre-amplifier	HP	8447D	2944A09358	03-07-2018	03-06-2019
Pre-amplifier	CD	PAP-1G18	11804	03-07-2018	03-06-2019
Spectrum analyzer	Rohde & Schwarz	FSP30	101454	03-07-2018	03-06-2019
Spectrum analyzer	Rohde & Schwarz	FSP40	100363	11-21-2018	11-20-2019
EMI Test Receiver	Rohde & Schwarz	ESRP7	101070	03-07-2018	03-06-2019
Cable	ZDECL	Z108-NJ-NJ-81	1608458	03-07-2018	03-06-2019
Cable	MICRO-COAX	MFR64639	K10742-5	03-07-2018	03-06-2019
Cable	SUHNER	SUCOFLEX100	58193/4PE	03-07-2018	03-06-2019

Conducted Emission:					
Test Equipment	Manufacturer	Model No.	Serial No.	Cal. Date (mm-dd-yy)	Cal. Due date (mm-dd-yy)
EMI Test Receiver	Rohde & Schwarz	ESCI	101189	03-07-2018	03-06-2019
Pulse Limiter	SCHWARZBECK	OSRAM 2306	9731	03-07-2018	03-06-2019
LISN	CHASE	MN2050D	1447	03-19-2018	03-18-2019
LISN	Rohde & Schwarz	ESH3-Z5	8438621/010	07-21-2018	07-20-2019
Cable	HP	10503A	N/A	03-07-2018	03-06-2019
EMI Test Software	AUDIX	E3	\	ersion: 6.110919/	b



# 6 Test results and Measurement Data

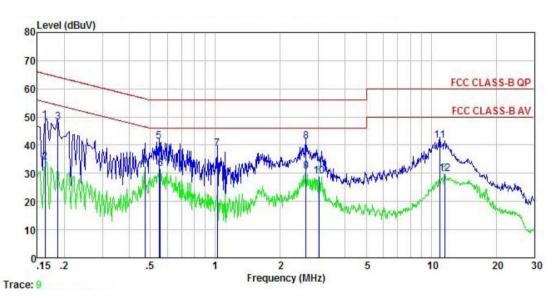
# **6.1 Conducted Emission**

Test Requirement:	FCC Part 15 B Section 15.10	FCC Part 15 B Section 15.107			
Test Method:	ANSI C63.4:2014				
Test Frequency Range:	150kHz to 30MHz	150kHz to 30MHz			
Class / Severity:	Class B				
Receiver setup:	RBW=9kHz, VBW=30kHz				
Limit:	Frequency range (MHz)	Lir	mit (dBµV)		
	, , , ,	Quasi-peak	Average		
	0.15-0.5	66 to 56*	56 to 46*		
	0.5-5	56	46		
	0.5-30	60	50		
	* Decreases with the logarith				
Test setup:	Reference Plan	ne			
	AUX Equipment   E.U.T   EMI   Receiver    Remark: E.U.T Equipment Under Test   LISN: Line Impedence Stabilization Network   Test table height=0.8m				
Test procedure	<ol> <li>The E.U.T and simulators are connected to the main power through a line impedance stabilization network(L.I.S.N.). The provide a 50ohm/50uH coupling impedance for the measuring equipment.</li> <li>The peripheral devices are also connected to the main power through a LISN that provides a 50ohm/50uH coupling impedance with 50ohm termination. (Please refers to the block diagram of the test setup and photographs).</li> <li>Both sides of A.C. line are checked for maximum conducted interference. In order to find the maximum emission, the relative positions of equipment and all of the interface cables must be changed according to ANSI C63.4: 2014 on conducted measurement.</li> </ol>				
Test environment:	Temp.: 22.5 °C Humid.: 55% Press.: 101kPa				
Test Instruments:	Refer to section 5.9 for details				
Test mode:	Refer to section 5.3 for details				
Test results:	Pass				



### Measurement data: 4G (RAM) + 64G (ROM)

Product name:	LTE Smart phone	Product model:	N6201L
Test by:	Carey	Test mode:	PC mode
Test frequency:	150 kHz ~ 30 MHz	Phase:	Line
Test voltage:	AC 120 V/60 Hz	Environment:	Temp: 22.5℃ Huni: 55%



#### Remark

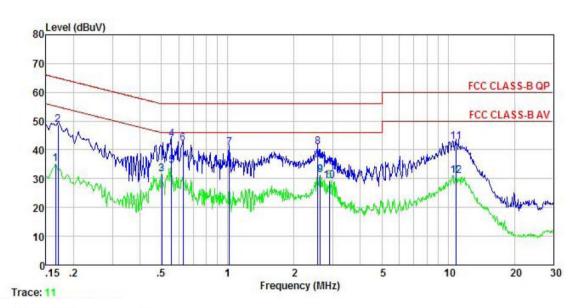
	Freq	Read Level	LISN Factor	Cable Loss	Level	Limit Line	Over Limit	Remark
	MHz	dBu∜	₫B	dB	dBu₹	dBu₹	<u>d</u> B	
1	0.162	37.63	0.17	10.77	48.57		-16.77	
2	0.162	22.98	0.17	10.77	33.92	55.34	-21.42	Average
3	0.186	37.09	0.16	10.76	48.01	64.20	-16.19	QP
4	0.471	21.66	0.12	10.75	32.53	46.49	-13.96	Average
5	0.549	30.40	0.12	10.76	41.28	56.00	-14.72	QP
6	0.555	20.82	0.12	10.76	31.70	46.00	-14.30	Average
7	1.021	27.71	0.13	10.87	38.71	56.00	-17.29	QP
2 3 4 5 6 7 8 9	2.636	30.14	0.16	10.93	41.23	56.00	-14.77	QP
9	2.636	19.65	0.16	10.93	30.74	46.00	-15.26	Average
10	3.025	17.77	0.16	10.92	28.85			Average
11	10.963	30.41	0.32	10.93	41.66		-18.34	
12	11.559	18.46	0.32	10.93	29.71			Average

#### Notes:

- 1. An initial pre-scan was performed on the line and neutral lines with peak detector.
- 2. Quasi-Peak and Average measurement were performed at the frequencies with maximized peak emission.
- 3. Final Level =Receiver Read level + LISN Factor + Cable Loss.



Product name:	LTE Smart phone	Product model:	N6201L
Test by:	Carey	Test mode:	PC mode
Test frequency:	150 kHz ~ 30 MHz	Phase:	Neutral
Test voltage:	AC 120 V/60 Hz	Environment:	Temp: 22.5℃ Huni: 55%



-			
к	em	ark	

	Freq	Read Level	LISN Factor	Cable Loss	Level	Limit Line	Over Limit	Remark
2	MHz	dBu∜	<u>dB</u>	dB	dBu₹	dBu∜	<u>d</u> B	
1 2	0.166 0.170	23.36 36.85	0.97 0.96	10.77 10.77	35.10 48.58		-20.06 -16.36	Average OP
3	0.502 0.555	19.78 31.84	0.97	10.76 10.76	31.51	46.00		Average
2 3 4 5 6 7 8 9	0.555	22.84	0.97	10.76	34.57	46.00	-11.43	Average
6	0.627 1.016	30.37 28.85	0.97 0.97	10.77 10.87	42.11 40.69		-13.89 -15.31	
8	2.567 2.636	29.08 19.44	0.99	10.94 10.93	41.01		-14.99 -14.64	QP Average
10 11	2.900 10.847	17.44 30.79	0.99	10.92 10.93	29.35 42.72	46.00		Average
12	10.905	19.17	1.00	10.93	31.10			Average

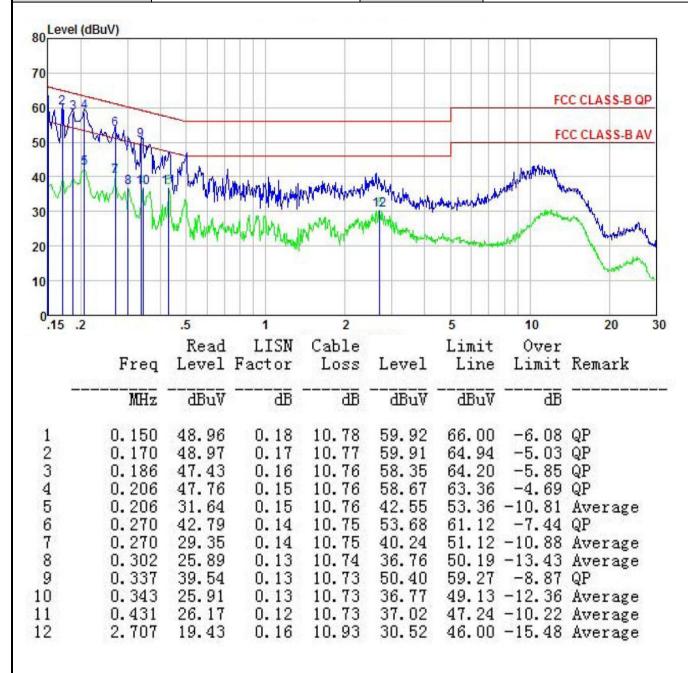
#### Notes:

- 1. An initial pre-scan was performed on the line and neutral lines with peak detector.
- 2. Quasi-Peak and Average measurement were performed at the frequencies with maximized peak emission.
- 3. Final Level =Receiver Read level + LISN Factor + Cable Loss.



#### 6G (RAM) + 128G (ROM)

Product name:	LTE Smart phone	Product model:	N6201L
Test by:	Carey	Test mode:	PC mode
Test frequency:	150 kHz ~ 30 MHz	Phase:	Line
Test voltage:	AC 120 V/60 Hz	Environment:	Temp: 22.5℃ Huni: 55%

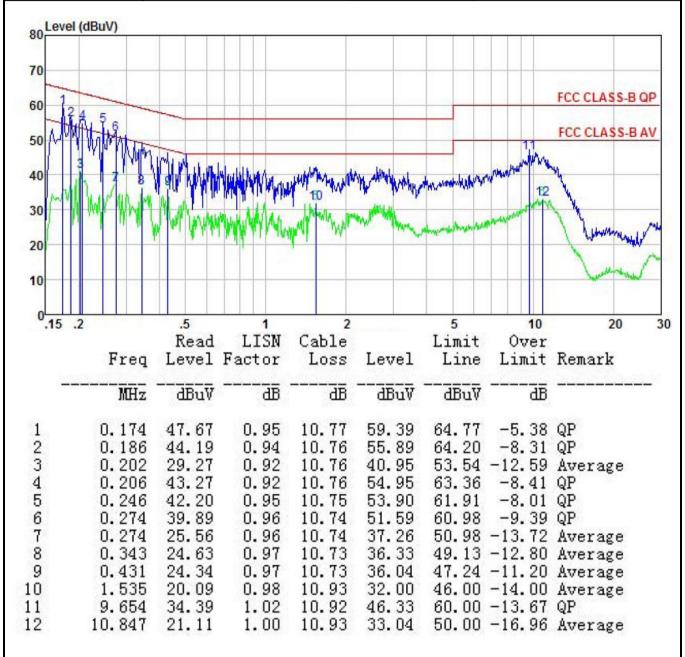


#### Notes:

- 4. An initial pre-scan was performed on the line and neutral lines with peak detector.
- 5. Quasi-Peak and Average measurement were performed at the frequencies with maximized peak emission.
- 6. Final Level =Receiver Read level + LISN Factor + Cable Loss.



Product name:	LTE Smart phone	Product model:	N6201L
Test by:	Carey	Test mode:	PC mode
Test frequency:	150 kHz ~ 30 MHz	Phase:	Neutral
Test voltage:	AC 120 V/60 Hz	Environment:	Temp: 22.5℃ Huni: 55%



#### Notes:

- 4. An initial pre-scan was performed on the line and neutral lines with peak detector.
- 5. Quasi-Peak and Average measurement were performed at the frequencies with maximized peak emission.
- 6. Final Level =Receiver Read level + LISN Factor + Cable Loss.



# 6.2 Radiated Emission

Test Requirement:	FCC Part 15 B	Section 1	5.109				1		
Test Method:		ANSI C63.4:2014							
Test Frequency Range:		30MHz to 6000MHz							
Test site:	Measurement Distance: 3m (Semi-Anechoic Chamber)								
Receiver setup:	Frequency								
Neceiver setup.	30MHz-1GHz	Quasi-		120kHz	300k		Quasi-peak Value		
	Above 4CII-	Pea		1MHz	3MF		Peak Value		
	Above 1GHz	RM	S	1MHz	3MF	Ηz	Average Value		
Limit:		Frequency Limit (dBuV/m @3m)					Remark		
	30MHz-88M			40.0			Quasi-peak Value		
	88MHz-216N			43.5			Quasi-peak Value		
	216MHz-960			46.0			Quasi-peak Value		
	960MHz-1G	SHz		54.0		(	Quasi-peak Value		
	Above 1GI	Ηz		54.0			Average Value		
Test setup:				74.0			Peak Value		
	Ground Plane — Above 1GHz	EUT mtable)	$\bigvee$		Antenna Searc Anten RF Test Receiver -	h na			





	1						
Test Procedure:	<ol> <li>The EUT was placed on the top of a rotating table 0.8 meters above the ground at a 3 meter semi-anechoic camber. The table was rotated 360 degrees to determine the position of the highest radiation.</li> <li>The EUT was set 3 meters away from the interference-receiving</li> </ol>						
		, which was i	•			-	
	3. The antenna height is varied from one meter to four meters above the ground to determine the maximum value of the field strength. Both horizontal and vertical polarizations of the antenna are set to make the measurement.						
	4. For each suspected emission, the EUT was arranged to its worst case and then the antenna was tuned to heights from 1 meter to 4 meters and the rotatable table was turned from 0 degrees to 360 degrees to find the maximum reading.						
	5. The test-receiver system was set to Peak Detect Function and Specified Bandwidth with Maximum Hold Mode.						
	6. If the emission level of the EUT in peak mode was 10dB lower than the limit specified, then testing could be stopped and the peak values of the EUT would be reported. Otherwise the emissions that did not have 10dB margin would be re-tested one by one using peak, quasi-peak or average method as specified and then reported in a data sheet.						
Test environment:	Temp.: 24 °C Humid.: 57% Press.: 1 01kPa						
Test Instruments:	Refer to se	ection 5.9 for	details				
Test mode:	Refer to se	ection 5.3 for	details				
Test results:	Passed						
Remark:	All of the crecorded	bserved valu	e above 6GH	Iz ware the n	iose floor ,	which were no	

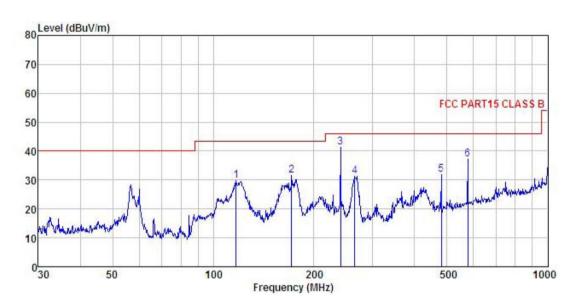


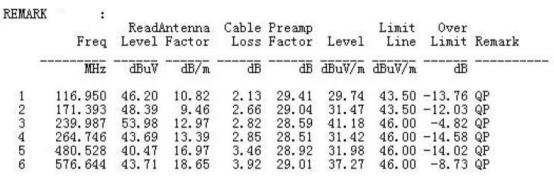


### Measurement Data: 4G (RAM) + 64G (ROM)

#### **Below 1GHz:**

Product Name:	LTE Smart phone	Product model:	N6201L
Test By:	Carey	Test mode:	PC mode
Test Frequency:	30 MHz ~ 1 GHz	Polarization:	Vertical
Test Voltage:	AC 120/60Hz	Environment:	Temp: 24℃ Huni: 57%





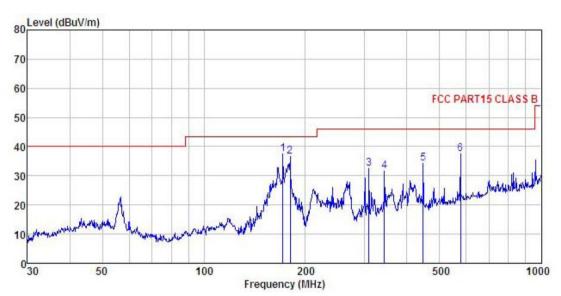
#### Remark:

<sup>1.</sup> Final Level = Receiver Read level + Antenna Factor + Cable Loss - Preamplifier Factor.

<sup>2.</sup> The emission levels of other frequencies are very lower than the limit and not show in test report.



Product Name:	LTE Smart phone	Product model:	N6201L
Test By:	Carey	Test mode:	PC mode
Test Frequency:	30 MHz ~ 1 GHz	Polarization:	Horizontal
Test Voltage:	AC 120/60Hz	Environment:	Temp: 24℃ Huni: 57%



	: Freq		Antenna Factor			Level	Limit Line	Over Limit	Remark
-	MHz	dBu∜	<u>dB</u> /m	<u>d</u> B	<u>dB</u>	dBuV/m	dBuV/m	<u>dB</u>	
1	171.393	54.40	9.46	2.66	29.04	37.48	43.50	-6.02	QP
2	180.017	53.02	9.80	2.73	28.97	36.58	43.50	-6.92	QP
2 3 4 5	308.913	44.29	13.79	2.97	28.47	32.58	46.00	-13.42	QP
4	343.180	42.66	14.47	3.08	28.55	31.66	46.00	-14.34	QP
5	446.414	43.76	16.06	3.19	28.86	34.15	46.00	-11.85	QP
6	576.644	43.84	18.65	3.92	29.01	37.40	46.00	-8.60	- T.

#### Remark:

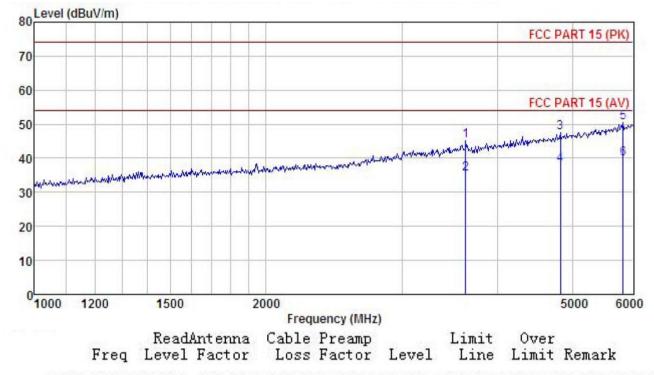
- 1. Final Level = Receiver Read level + Antenna Factor + Cable Loss Preamplifier Factor.
- 2. The emission levels of other frequencies are very lower than the limit and not show in test report.





#### Above 1GHz:

Product Name:	LTE Smart phone	Product model:	N6201L
Test By:	Carey	Test mode:	PC mode
Test Frequency:	1 GHz ~ 6 GHz	Polarization:	Vertical
Test Voltage:	AC 120/60Hz	Environment:	Temp: 24℃ Huni: 57%



	Freq	Level	Factor	Loss	Factor	Level	Line	Limit	Remark
	MHz	dBu∜	dB/m	<u>ab</u>	<u>ab</u>	$\overline{dBuV/m}$	$\overline{dBuV/m}$	<u>ab</u>	
1	3634.910	49.25	29.27	5.93				-28.94	
2	3634.910	39.73	29.27	5.93	41.59	35.54	54.00	-18.46	Average
3	4821.757	48.44	31.62	6.81	41.82	47.49	74.00	-26.51	Peak
4	4821.757	38.88	31.62	6.81	41.82	37.93	54.00	-16.07	Average
5	5821.207	48.77	32.99	7.89	42.02	50.38	74.00	-23.62	Peak
6	5821.207	38.18	32.99	7.89	42.02	39.79			Average

#### Remark:

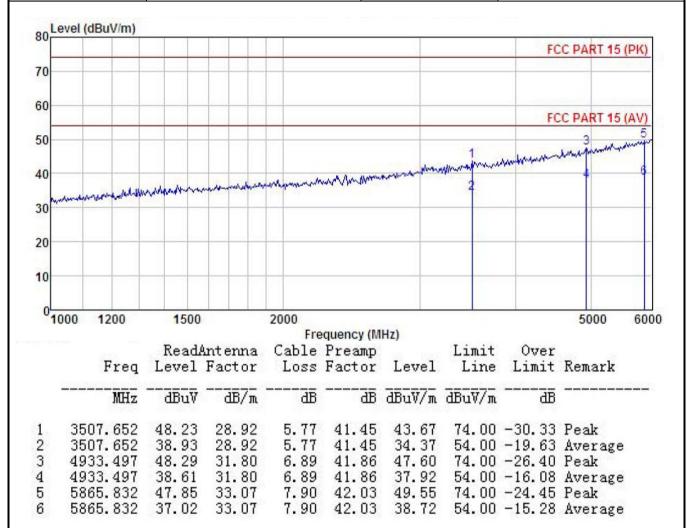
<sup>1.</sup> Final Level = Receiver Read level + Antenna Factor + Cable Loss - Preamplifier Factor.

<sup>2.</sup> The emission levels of other frequencies are very lower than the limit and not show in test report.





Product Name:	LTE Smart phone	Product model:	N6201L
Test By:	Carey	Test mode:	PC mode
Test Frequency:	1 GHz ~ 6 GHz	Polarization:	Horizontal
Test Voltage:	AC 120/60Hz	Environment:	Temp: 24℃ Huni: 57%



#### Remark:

<sup>1.</sup> Final Level = Receiver Read level + Antenna Factor + Cable Loss - Preamplifier Factor.

<sup>2.</sup> The emission levels of other frequencies are very lower than the limit and not show in test report.

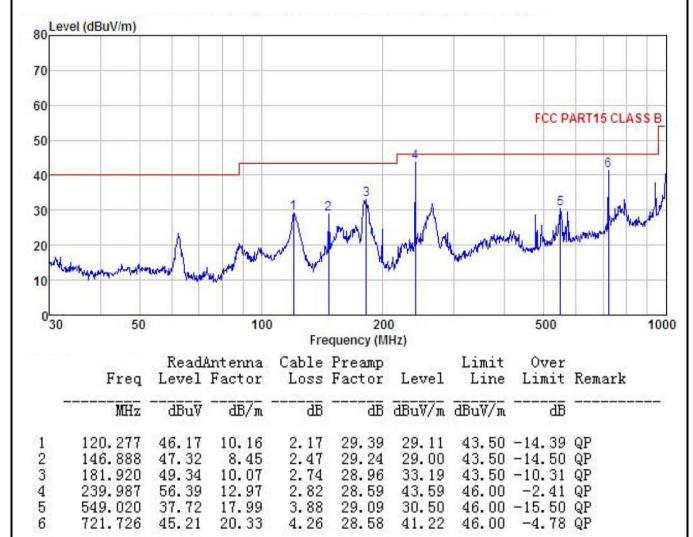




#### 6G (RAM) + 128G (ROM)

#### **Below 1GHz:**

Product Name:	LTE Smart phone	Product model:	N6201L
Test By:	Carey	Test mode:	PC mode
Test Frequency:	30 MHz ~ 1 GHz	Polarization:	Vertical
Test Voltage:	AC 120/60Hz	Environment:	Temp: 24℃ Huni: 57%



#### Remark:

<sup>3.</sup> Final Level = Receiver Read level + Antenna Factor + Cable Loss - Preamplifier Factor.

<sup>4.</sup> The emission levels of other frequencies are very lower than the limit and not show in test report.





roduct	Name:	LTE Sma	art phone		Pro	oduct mod	lel:	N6201L			
est By:		Carey 30 MHz ~ 1 GHz				st mode:	PC mode			PC mode	
est Fre	quency:					larization:	F	Horizontal		Horizontal	
est Vol	tage:	AC 120/6	60Hz		En	vironment	: 7	Гетр: 24°(	C	Huni: 57	
Leve	el (dBuV/m)										
80	a (abaviii)								- 1		
70											
60								FCC PAR	RT15	CLASSB	
50											
40					<del>- 9</del>				6		
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20	50 Freq			Cable	quency (MH	in the states	Limit Line		Res	100	
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30 20 10 0 30	Freq MHz	Level dBuV	ntenna Factor ——dB/m	Cable Loss dB	puency (MH Preamp Factor dB	Level	Line dBuV/m	Over Limit ———————————————————————————————————		100	
30 20 10 0 30	Freq MHz 90.220	Level dBuV 50.12	ntenna Factor dB/m	Cable Loss dB	puency (MH Preamp Factor dB 29.57	Level dBuV/m 32.62	Line  dBuV/m  43.50	Over Limit dB	QP	100	
30 20 10 0 30	Freq MHz 90.220 98.833 181.920	Level dBuV 50.12 47.84 57.08	ntenna Factor dB/m 10.04 11.51 10.07	Cable Loss dB 2.03 1.97 2.74	uency (MH Preamp Factor dB 29.57 29.53 28.96	Level  dBuV/m  32.62 31.79 40.93	Line dBuV/m 43.50 43.50 43.50	Over Limit ———————————————————————————————————	QP QP QP	100	
20	Freq MHz 90.220 98.833	dBuV 50.12 47.84	antenna Factor dB/m 10.04 11.51	Cable Loss dB 2.03 1.97	uency (MH Preamp Factor dB 29.57 29.53 28.96 28.59	Level dBuV/m 32.62 31.79	Line dBuV/m 43.50 43.50	Over Limit 	QP QP QP QP	100	

#### Remark

<sup>3.</sup> Final Level = Receiver Read level + Antenna Factor + Cable Loss - Preamplifier Factor.

<sup>4.</sup> The emission levels of other frequencies are very lower than the limit and not show in test report.





### Above 1GHz:

Prod	uct Name:	LTE Sm	art phone		Pro	oduct mod	lel:	N6201L				
Test	Ву:	Carey			Carey Test mode:			Carey Test mode: PC mode			PC mode	
Test	Frequency:	1 GHz ~	GHz ~ 6 GHz			larization:		Vertical				
Test	Voltage:	AC 120/	60Hz		En	vironment	:	Temp: 24℃ Huni: 57%				
80 <sup>L</sup>	.evel (dBuV/m)											
80								FC	C PART 15 (PK)			
70								9 407				
60								FC	DART 45 (AVA			
50									C PART 15 (AV)			
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40			rest causes	K m. de di	when the work of the	A-Mary Conference	grand which	Wilder	6			
30	gharman handra de de de la companya	of the man of the state	depterment and action	A Parent a human			_					
20												
10												
0	000 1200	1500		2000 Free	quency (MH	l7)			5000 6000			
		Read.	Ant enna		Preamp		Limi	t Over				
	Freq		Factor		Factor		Lin		Remark			
	MHz	dBu∜	dB/m	<u>dB</u>	<u>ab</u>	dBuV/m	dBu₹/	m dB				
1 2 3	3634.910 3634.910 4310.849	49.25 39.73 48.65	29.27 29.27 30.77	5.93 5.93 6.58	41.59 41.59 41.90	45.06 35.54 46.40	54.0	0 -28.94 0 -18.46 0 -27.60	Average			
2 3 4 5 6	4310.849 5821.207 5821.207	37.31 48.77 37.18	30.77 32.99 32.99	6.58 7.89 7.89	41.90 42.02 42.02	35.06 50.38 38.79	54.0 74.0	0 -18.94 0 -23.62	Average			

#### Remark:

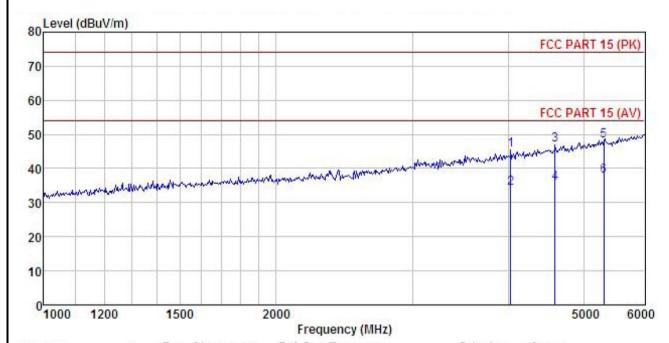
<sup>3.</sup> Final Level = Receiver Read level + Antenna Factor + Cable Loss - Preamplifier Factor.

<sup>4.</sup> The emission levels of other frequencies are very lower than the limit and not show in test report.





Product Name:	LTE Smart phone	Product model:	N6201L
Test By:	Carey	Test mode:	PC mode
Test Frequency:	1 GHz ~ 6 GHz	Polarization:	Horizontal
Test Voltage:	AC 120/60Hz	Environment:	Temp: 24℃ Huni: 57%



	Freq		Antenna Factor				Limit Line	Over Limit	Remark
	MHz	dBu₹		<u>d</u> B	<u>dB</u>	$\overline{dBuV/m}$	dBuV/m	<u>db</u>	
1	4024.520	48.81	30.25	6.15	41.81	45.61	74.00	-28.39	Peak
2	4024.520	37.55	30.25	6.15	41.81	34.35	54.00	-19.65	Average
3	4594.102	48.62	31.26	6.90	42.14	47.03	74.00	-26.97	Peak
4	4594.102	37.42	31.26	6.90	42.14	35.83	54.00	-18.17	Average
5	5311.469	48.02	32.22	7.10	41.90	48.04		-25.96	
6	5311.469	37.76	32.22	7.10	41.90	37.78			Average

#### Remark:

- 3. Final Level = Receiver Read level + Antenna Factor + Cable Loss Preamplifier Factor.
- 4. The emission levels of other frequencies are very lower than the limit and not show in test report.